

Search Notes

Application/Control No.

10/067,350

Examiner

Ba Huynh

Applicant(s)/Patent under
Reexamination

FUJII ET AL.

Art Unit

2179

SEARCHED

Class	Subclass	Date	Examiner
715	751-759	7/20/2007	HB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR